Power MOSFET

25 V, 87 A, Single N-Channel, ICEPAK

Features

- Low Package Inductance
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Dual Sided Cooling Capability
- Compatible with SQ Footprint and Outline
- This is a Pb-Free Device

Applications

- CPU Power Delivery
- DC-DC Converters
- Optimized for both Synch FET and Control FET

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	25	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	15.8	Α
Current R _{θJA} (Note 1)		T _A = 70°C		12.6	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.2	W
Continuous Drain		T _A = 25°C	I _D	87	Α
Current R _{θJ-PCB} (Note 2)	Steady State	T _A = 70°C		48	
Power Dissipation $R_{\theta J-PCB}$ (Note 2)	State	T _A = 25°C	P _D	65	W
Continuous Drain		T _C = 25°C	I _D	64	Α
Current R _{θJC} (Note 1)		T _C = 70°C		51	
Power Dissipation R _{0JC} (Note 1)		T _C = 25°C	P _D	36	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I_{DM}	124	Α
Current Limited by Package T _A = 25°C			I _{Dmax}	50	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to 150	°C
Source Current (Body Diode) (Note 1)			IS	42	Α
Drain to Source DV/DT			dV/dt	6.0	V/ns
Single Pulse Drain-to–Source Avalanche Energy ($T_J = 25^{\circ}C$, $V_{DD} = 25$ V, $V_{GS} = 10$ V, $I_L = 23$ A _{pk} , $L = 0.3$ mH, $R_G = 25$ Ω)			E _{AS}	79.4	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	270	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
- 2. Measured with a T_J of approximately 90°C using 1 oz Cu board.
- 3. Surface mounted on FR4 board using 1 sq-in pad, 2 oz Cu.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
25 V	5.4 mΩ @ 10 V	87 A
25 V	8.6 mΩ @ 4.5 V	07 A



ICEPAK B1 PAD CASE 145AD

MARKING DIAGRAM



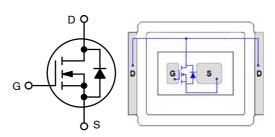
B4893 = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)



N-CHANNEL MOSFET

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMKB4893NT1G	ICEPAK (Pb-Free)	1500/Tape & Reel
NTMKB4893NT3G	ICEPAK (Pb-Free)	5000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

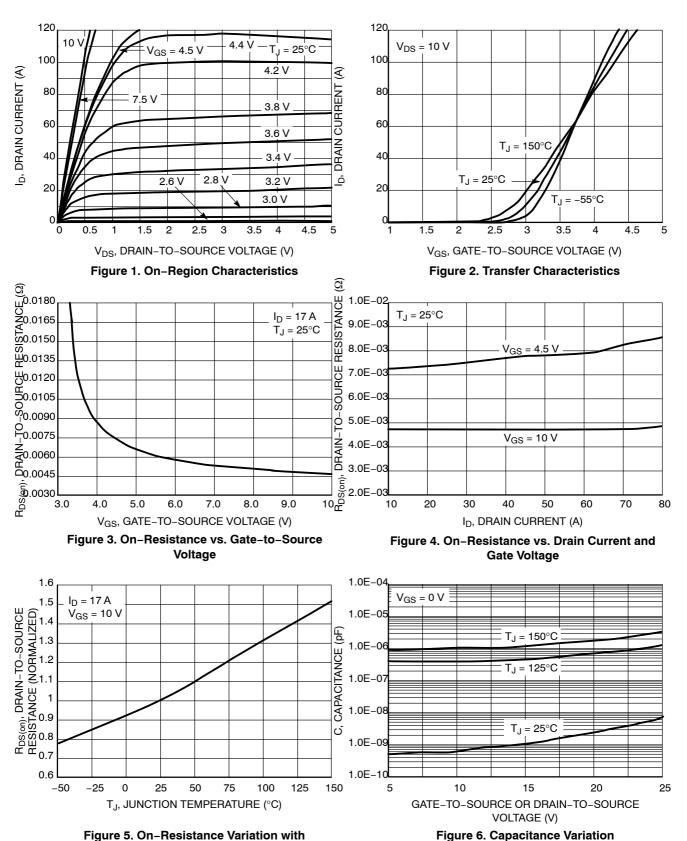
Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Note 1)	$R_{ heta JC}$	3.5	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	58	
Junction-to-Ambient - Steady State (Notes 2 and 3)	$R_{ heta JA}$	20	
Junction-to-PCB (Note 2)	$R_{\theta J-PCB}$	1.0	

ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J			23		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{GS} = 0 \text{ V}, V_{DS} = 20 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±100	nA
ON CHARACTERISTICS (Note 4)						
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$	1.4		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J			6.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D = 17 A		4.5	5.4	mΩ
		V _{GS} = 4.5 V, I _D = 13 A		7.2	8.6	1
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D = 10 A		40		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE				
Input Capacitance	C _{iss}			1643		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V		405		
Reverse Transfer Capacitance	C _{rss}			233		
Total Gate Charge	Q _{G(TOT)}			13.1		nC
Threshold Gate Charge	Q _{G(TH)}	.,		1.8		1
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 13 \text{ A}$		5.0		1
Gate-to-Drain Charge	Q_{GD}			5.1		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 13 A		24.9		nC
SWITCHING CHARACTERISTICS (No	ote 5)			•	•	-
Turn-On Delay Time	t _{d(on)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 13 A, R_{G} = 1.8 Ω		10.7		ns
Rise Time	t _r			23.6		1
Turn-Off Delay Time	t _{d(off)}			16.6		1
Fall Time	t _f			4.2		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS			•	•	-
Forward Diode Voltage	V _{SD}	T _J = 25°C		0.82	1.0	V
		$V_{GS} = 0 \text{ V, } I_S = 13 \text{ A}$ $T_J = 125^{\circ}\text{C}$		0.67		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$		23.3		ns
Charge Time	t _a			7.6		1
Discharge Time	t _b	$I_{S} = 13 \text{ A}$		15.7		1
Reverse Recovery Charge	Q _{RR}			16.5		nC
PACKAGE PARASITIC VALUES				•	_	
Gate Resistance	R_{G}	T _A = 25°C		1.6	2.5	Ω

^{4.} Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



Temperature

Figure 6. Capacitance Variation

TYPICAL CHARACTERISTICS

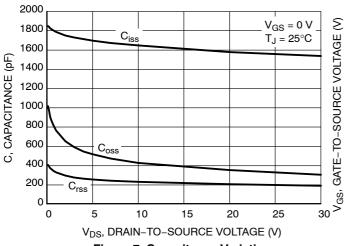


Figure 7. Capacitance Variation

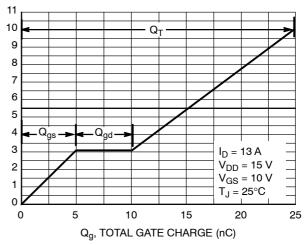


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

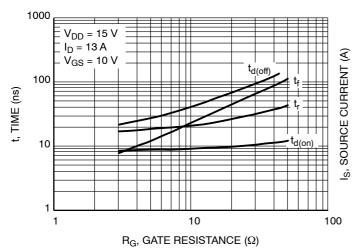


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

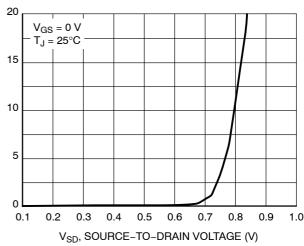


Figure 10. Diode Forward Voltage vs. Current

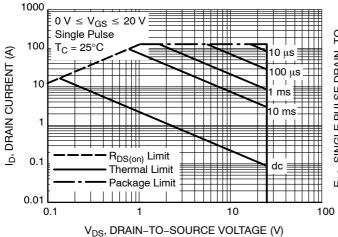


Figure 11. Maximum Rated Forward Biased Safe Operating Area

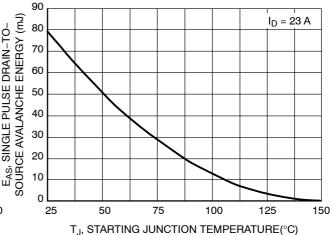
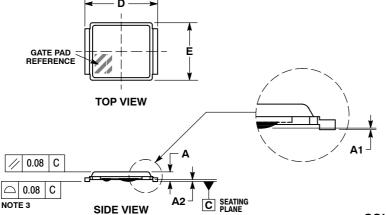


Figure 12. Maximum Avalanche Energy vs.
Starting Junction Temperature

PACKAGE DIMENSIONS

ICEPAK 4.8x3.8 - B1 PAD CASE 145AD-01 **ISSUE O**

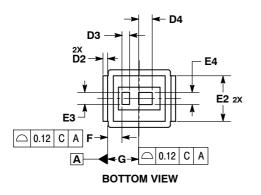


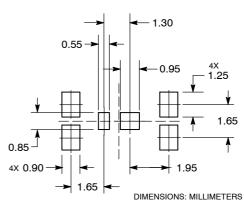
NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- CONTROLLING DIMENSION: MILLIMETERS.
 COPLANARITY APPLIES TO THE FLANGES
- OF LEADFRAME ONLY

-			
	MILLIMETERS		
DIM	MIN	MAX	
Α	0.61	0.68	
A1	0.02	0.08	
A2	0.08	0.17	
D	4.75	4.85	
D2	0.35	0.45	
D3	0.44	0.48	
D4	0.84	0.88	
E	3.70	3.95	
E2	2.75	2.85	
E3	0.74	0.78	
E4	0.74	0.78	
F	0.97 BSC		
G	2.07 BSC		

SOLDERING FOOTPRINT*





*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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